

Top of the Rion Range of Sound Level Meters



Sound level meter and 1/3 octave band real-time analyzer NA-28

Easy to use compact design with comprehensive features

Rion's priorities for on-site measurements are speed, ease of use, quality and reliability.

The New NA-28 is the top of the Rion range of sound level meters and analyzers. It combines cutting edge technology with excellent quality and unrivalled ease of use.

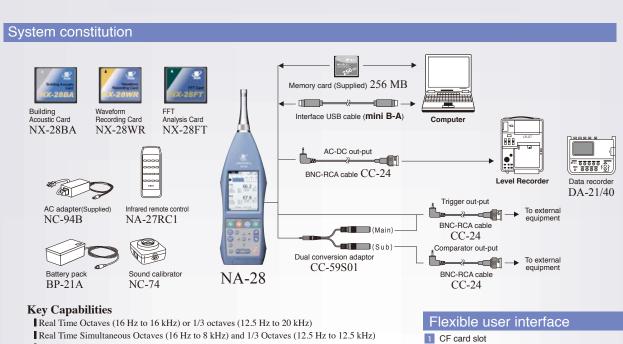
Sound level meter and 1/3 octave band real-time analyzer NA-28

Key Features Include:

- Ease of use main functions on dedicated, backlit keys
- Superb high-contrast backlit TFT-LCD color display
- Simultaneous measurement and display of 1/1 and 1/3 octaves
- One keystroke to switch between sound level meter and analyzer display
- Massive storage capacity using text files stored to CompactFlash memory cards (CF card)

Color Displa

- Flexible and simple PC connectivity (CF card and USB Virtual Disk)
- Exceptional battery life using standard alkaline batteries, approx. 16 hours



- Data stored as text files direct to CF card
- Measures and logs L_{eq} , L_{max} , L_{min} and 5 percentile values (L_N) in octaves and/or 1/3 octaves
- Auto Stores 300 000 data sets or 1 000 hours of 1 second 1/3 octaves onto 2 GB CF card
- Auto Stores 1 000 data sets or 10 000 of 1 second 1/3 octaves to internal memory
- Manual Storage for 1 000 data sets internally or 100 000 data sets to 2 GB CF card
- Linearity 110 dB in Sound Level Meter Mode and 95 dB in Analyzer Mode
- 16 hours battery life with 4 Alkaline 'C' Cells
- Main and Sub-Channel for simultaneous selection of 2 time or frequency weightings
- F (Fast), S (Slow), 10 ms Time Weightings plus Peak & Impulse on Sub-Channel

OCT&BOCT

HEINI LZF

Time versus level display

with 1/1,1/3 octave analysis

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- Data transfer using CF card or USB (meter/CF card appearing as virtual disk)
- Measurement can be started by internal or external trigger
- Comparator output to trigger external devices
- AC and DC outputs of main and/or sub-channel
- Expandable functionality using programme cards

Key Options

OCT&BOCT

MATIN LZF

1/30ct

Analysis mode screen

Screen display-Example

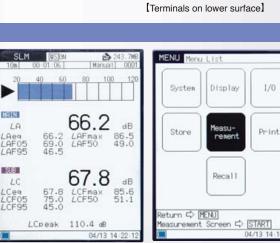
2 kHz 1.6 kHz

(Simultaneous 1/1 & 1/3 octave band display)

Building Acoustics Programme Card

ß

Uncompressed WAV file recording Programme Card



2 Infrared remote control sensor

3 2

4 Two-way trigger input/comparator output terminal

5

6 7

1/0

4

Menu list screen

3 AC adapter terminal

5 AC output terminal

6 DC output terminal

7 USB terminal

Sound level meter mode screen (Sound level display)



888

Memory Card 256 MB MC-25LC1 SUPPLIED 12.



Waveform Recording Card NX-28WR

NX-28WR is a program card that provides the NA-28 with recording functions. Using the NA-28 and NX-28WR in combination makes it possible to measure sound pressure levels together with sound pressure waveforms during frequency analysis. Since the data are recorded in uncompressed WAVE files, they can be handled with software*1 compatible with the WAVE and analyzed.

*1 Software may not be compatible depending on sampling frequencies. If the software is not compatible, use a sampling converter to change sampling frequencies.

Sampling Frequencies & CF Card Recording Time

Bamping riequencies a or Bara rieborang rine			
	256 MB	2 GB	
48 kHz	30 m	4 h 40 m	
24 kHz	1 h	9 h 20 m	
12 kHz	2 h 10 m	18 h 50 m	
64 kHz	20 m	3 h 30 m	
32 kHz	50 m	7 h	
16 kHz	1 h 40 m	14 h 10 m	
Description for a second distance of the test of the test of the second second field of the second for the test			

Recording time would be somewhat changed by the number of files including recording da

	Specifications
Devices of we could also sound at this we could be to improve distance interview.	Sampling frequency
Feature 1 Replay of recorded sound – It is possible to immediately identify	Octave, 1/3 octave 48 kHz, 24 kHz, 12 kHz
unnecessary or unknown sounds by listening to the recorded data	*2 simultaneous analysis
*2 Using Windows Medi	Sound meter, octave analysis, 64 kHz, 32 kHz, 16 kHz
•	1/3 octave analysis
I conducted sound analysis but there are irregularities in the analysis result	Ilts Quantization bit length 16 bit
and I don't know what causes them.	Data format WAVE
I detected the sound of a police car siren during measurement of traffic no	Dise Frequency weighting Z weighting (flat response) (fixed)
and I would like to exclude it.	Recording functions
I measured sound levels and would like to listen to specific events.	Event mode Level recording, interval recording,
	manual recording
Dependencie of recorded example. It is preside to record, we deter he	Total mode Total recording
Feature 2 Reanalysis of recorded sound – It is possible to reanalyze data ba	Sed Simultaneous use with Building
on the recorded waveforms using waveform analysis software	Acoustics Card NX-28BA
	During sound insulation and Total recording
I conducted 1/1 octave band analysis but I need to be able to conduct 1/3 of the second se	octave impact sound measurement
band analysis.	During reverberation time Total recording
I conducted 1/3 octave band analysis but I need to be able to conduct and	alvses measurement with pre-trigger (1 s)
in more detail by FFT.	Replay and reanalysis cannot be made with the NA-28 unit.
	hopiay and realitayois cannot be made with the two 20 anit.
	and an alternal costs and taken be attacked
Software Recorded data by NX-28WR can be displayed	and analyzed using optional software.
	The second se
Optional accessory Opt	ional accessory
Waveform	veform 🔤 -
processing software anal	ysis software 🧱 🛌
AS-70 CA	F-WAVE 📰 -
(This software)	vare is a product of Catec Inc.)
V as meaning a second s	and the first first first and the
Waveform analysis screen	Spectrum map screen
·	

NX-28FT program card adds FFT analysis capability to NA-28. Analysis frequency range: 20 kHz (fixed) Number of analysis lines: 8,000 (fixed) (frame time 400 ms, frequency resolution 2.5 Hz) FFT Card Specifications FFT Analysis Card 8 Standard compliance ISO 1996-2: 2007 Annex C * Main channel all-pass value and FFT analysis Measurement mode (FFT mode) Sub-channel all-pass value NX-28FT Simultaneous measurement of INST and LIN or MAX Measurement items Measurement time 1 to 999 seconds Dynamic range 100 dB ▲ 1927MB **WSOFF** 1927MB WS OFF alvsis freque 20 kHz (fixed) cy range Hanning 20s Hanning 15 1s Time window functions Hanning, Rectangular Number of spectrum lines 8,000 (fixed) (frame time 400 ms, frequency resolution 2.5 Hz) 80 80 Sampling frequency 48 kHz (fixed) Display Simultaneous display of FFT analysis result and all-pass level Measurement screen Number of FFT display lines Zoom ratio 200 50 x1, x2, x5, x10, x20, x40 50 Top list screen List display of frequency and level values for top 20 lines, in descending order Trigger Level trigger Controls start of measurement and memory store operation Measurement starts when threshold level (selectable in 1 dB steps) is exceeded, and ends after preset 20 20 measurement time has elapsed. Trigger source: main channel all-pass value only. Slope fixed to +. External trigger Measurement starts at falling edge of logic level signal supplied to trigger input Store function -10 dB 20000.0 Manual store Stores measurement results Freq(Hz) x40 Freg(Hz) x 1675.0 87 1177.5 Number of data sets 71.6 dB 71.6 dB 1427.5 Hz 1427.5 Hz CF card*2 Max, 20 store names, with up to 100 data sets each (Store to internal memory not supported) 74.9dB 75.2æ 75.2 dB LZ 74.9dB Allows waveform recording under measurements for LIN. MAX. Cor on with NX-28WB Ð 08/18 15:11:50 08/18 15:13:14 Waveform data stored together with manual store data on CF card. *1 Only frequency analysis is performed on unit. Tonal index calculation is performed on computer Measurement screen (zoom factor x1) Measurement screen (zoom factor x40) *2 Use only RION supplied cards for assured operation.



Building Acoustic Card NX-28BA

Screen display – Example

Measurement Mode	AirRm(D)
Store Name	DD_0001
Measurement Time	10s
Source Position	2
Source Room Meas. Pos.	5
Receive Room Setting	
Measurement Position	5
BGN Mode	Before
Source Room Data 🛡	None
Surface Area	172.0#
Room Volume	043.0#
Return 🖒 [MENU]	
Measurement Screen 🖒 🛽	TART
4 06	/11 16:43:2

AirRm 10s 00	50FF :10 S.N	1921) . Q
R'w	40	dB
Dn.w	33	dB
DnT,W	39	dB
С	0	dB
Ctr	-2	dB
DnT,A,k	40	dB
I lu,k	-12	dB
8:	2007/06/1	3 15:33:2
ingle-number guantitie	es of	

airborne sound insulation between rooms



Measured value list of reverberation time

NX-28BA is a program card used in NA-28 for simple and easy measurement of airborne and floor impact sound insulation of buildings and the reverberation time. The measurements conforming to ISO and single-number quantities can also be calculated by the main body of NA-28. Data is stored as text files. Furthermore, when used in conjunction with the waveform recording card NX-28WR, sound waveforms during measurement can be recorded simultaneously.

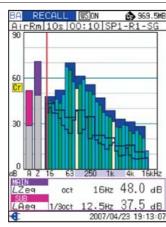
Applicable specifications

ISO 140-4 Accustics – Measurement of sound insulation in buildings and of building elements – Part 4: Field measurements of airborne sound insulation between rooms ISO 140-7 Accustics – Measurement of sound insulation in buildings and of building elements – Part 7: Field measurements of impact sound insulation of floors ISO 717-1 Accustics – Rating of sound insulation in buildings and of building elements – Part 1: Airborne sound insulation

ISO 717-2 Acoustics - Rating of sound insulation in buildings and of building elements - Part 2: Impact sound insulation

ISO 140-5* Acoustics – Measurement of sound insulation in buildings and of building elements – Part 5: Field measurements of airborne sound insulation of façade elements and façades ISO 16032* Acoustics – Measurement of sound pressure level from service equipment in buildings – Engineering method

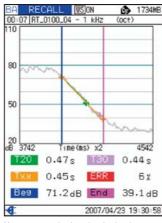
*The main body performs measurement only.



Measurement results overlaid with background noise (for octave, 1/3 octave simultaneous analysis)

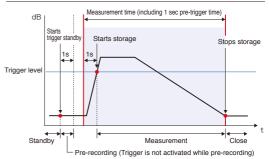
BA	RECALL				1921MB
Imp	-L 10s 0	00:00	S.N.	. Q	
	L'n,w		61	dE	3
	L'nT,W		60	dE	3
	L'nT,A		58	dE	3
	CI		-2	dE	3
	Ico		1	dE	3
•		200	7/04/1	8 14	:15:47

Single-number quantities of floor impact sound insulation (light impact source)



Measurement results of reverberation time decay curve

Measurement of reverberation decay curve



pecification

Specifications	
Analysis mode	Real-time octave band analysis, Real-time 1/3 octave band analys
	Real-time octave, 1/3 octave band simultaneous analysis
	(Sound level meter mode is not available)
Measurement items	Instantaneous sound pressure level Lp
(vary with measurement mode)	Equivalent continuous sound pressure level Leg
	Maximum instantaneous sound pressure level Lmax
Measurement of airborr	he sound insulation between two rooms
Settings	Measurement time 1 to 60 sec
	Number of setting sound sources 1 to 8 points
	Number of measurement points in sound source room 1 to 10 points
	Number of measurement points in sound receptor room 1 to 10 point
	Background noise measurement mode
	None (none)/Once (1 point)/Before/During
Calculations	Average measured value, single number quantity,
Calodiationio	insulation factor value (D-value)
Display	Lp/Leq (Background noise sound level),
Display	Lp/Leq/Lmax (Sound level in sound receiving room)
	Displays results overlaid with background noise
	(for measurement in sound receiving room)
	Displays alarm when the SPL difference with background noi
	is too small (for measurement in sound receiving room)
	npact sound insulation (for light impact source)
Settings	Measurement time 1 to 60 sec
	Number of setting sound sources 1 to 8 points
	Number of measurement points in sound receiving room 1 to 10 point
	Background noise measurement mode
	None (none)/Once (1 point)/Before/During
Calculations	Average measured value, single number quantity,
	insulation factor value (LL-value)
Display	Lp/Leq (Background noise sound level),
	Lp/Leq/Lmax (Sound level in sound receiving room)
	Displays results overlaid with rating curve
	Displays results overlaid with background noise
	Displays alarm when the SPL difference with background noise is too sn
Measurement of floor im	pact sound insulation (for heavy impact source)
Settings	Measurement time 1 to 60 sec
	Number of setting sound sources 1 to 8 points
	Number of measurement points in sound receiving room 1 to 10 point
	Number of measurements 1 to 5 times
	Background noise measurement mode
	None (none)/Once (1 point)/Before/During
Calculations	Insulation factor value (LH-value)
Display	Lp/Leq (Background noise sound level),
	Lp/Lmax (Sound pressure level in sound receiving room)
	Displays results overlaid with rating curve
	Displays results overlaid with background noise
	Displays alarm when the SPL difference with background noise is too sn
Measurement of indoor	
Calculations	Indoor noise rating value (NC-value or N-value)
Display	Displays results overlaid with rating curve
Measurement of reverberation time	
Settings	Measurement time 2 to 60 sec (varies with sampling cycle)
- s	Repeat count 1 to 10 times
Calculations	T20, T30 (using the least squares method)
Calculations	
Dioplay	Reverberation time calculated for random segments
Display	Averaged reverberation time, reverberation decay curve
Other measurements	Measurement of exterior wall sound insulation,
Other and the little a	Measurement of equipment noise
Other capabilities	Dedicated address display and Auto-increment,
	Alarm display, Settings change monitoring function,
	Waveform recording function (NX-28WR is separately needed)

Specifications

Applicable specifications		Sound level meter: Measurement method precision sound level meter IEC 61672-1: 2013 Class 1 IEC 61260 : 1995 Class 1 ANSI S1.4-2014 Class 1 ANSI S1.11-2004 Class 1 JIS C 1509-1: 2005 Class 1 JIS C 1509-1: 2005 Class 1		
Measurement functions		JIS C 1514 : 2002 Class 1 With both a sound level meter mode and analyzer mode, it is capable of simultaneous main channel and sub-channel measurement in either mode. Time and frequency weighting are set separately for the main and sub-channels.		
Measurement modes				
	Sound level meter mode	Measurement of all-pass values indicated in the measurement items below in the main or sub-channel Measurement of either Lpeak or Ltms in the sub-channel		
	Analyzer mode	Real-time octave and 1/3 octave band analysis and all-pass measurement in the main channel Only all-pass measurement in the sub-channel		
	L Measurement items	Simultaneous measurement of all items in the selected time weighting and frequency weighting characteristics 1) Instantaneous sound pressure level <i>L_p</i> 2) Equivalent continuous sound pressure level <i>L_{eq}</i> 3) Sound exposure level <i>L_e</i> 4) Maximum sound pressure level <i>L_{max}</i> APMax and BandMax can be selected as maximum 5) Minimum sound pressure level <i>L_{mm}</i> 6) Maximum 5 time ratio sound levels <i>L_V</i> (1 to 99 %, 1 % Step) Calculation from <i>L_p</i> or <i>L_{eq}</i> , 1sec One of the following is possible in the sub-channel in the sound level meter mode: Peak sound level <i>L_{peak}</i>		
Mor	asurement time	Frequency weighting characteristics are the same as sub-channel		
	rophone and	1 to 59 sec, 1 to 59 min, 1 to 24 hours Microphone: UC-59 Sensitivity: -27 dB±2 dB (re 1 V/Pa)		
	amplifier	Preamplifier: NH-23		
Mea	asurement range	A 25 dB to 138 dB C 33 dB to 138 dB Z 38 dB to 138 dB		
	al range characteristics, 1 kHz)	25 dB to 140 dB		
Мах	timum peak sound level asurement	143 dB		
	erent noise	A 17 dB or less C 25 dB or less		
Fre	quency range	Z 30 dB or less 10 Hz to 20 kHz		
	alysis frequency range	Center frequency		
	Octave analysis	16 Hz to 16 kHz (simultaneous analysis : up to 8 kHz)		
	1/3 octave analysis	12.5 Hz to 20 kHz (simultaneous analysis : up to 12.5 kHz)		
	quency weighting	A, C and Z		
	e weighting			
- H	Main channel Sub-channel	F (Fast), S (Slow), 10 ms F (Fast), S (Slow), 10 ms, Impulse		
_	ear operating range			
	All-pass (A-characteristics)	110 dB		
- H	Spectrum	95 dB		
Lev	el range			
	Sound level meter mode	Bar graph display range: maximum 100 dB 30 dB to 130 dB 20 dB to 120 dB 20 dB to 110 dB 20 dB to 100 dB 20 dB to 90 dB 20 dB to 80 dB		
	Analyzer mode	Bar graph display range: 90 dB 40 dB to 130 dB 30 dB to 120 dB 20 dB to 110 dB 10 dB to 100 dB 0 dB to 90 dB -10 dB to 80 dB		
	npling frequency			
- H	Leq, LE, Lmax, Lmin, Lpeak	15.6 μ s (20.8 μ s for octave, 1/3 octave simultaneous analysis)		
	L _N rection functions	100 ms		
-	Windscreen correction	Frequency response correction to ensure standard compliance with windscreen installed correction on/off setting via menu		
	Diffuse sound field correction	Correction of frequency characteristics in order to comply with standards (ANSI S1.4) in diffuse sound fields Correction function on/off operation implemented on the menu screen		
Display		Color semi-transparent TFT-LCD display with backlight (240 x 320 dots)		
	Refresh cycle	100 ms Controls measurement and memory storage start.		
Ĕ	Level 1	Measurement starts with the trigger level (1 dB intervals) as threshold and stops when the set measurement times elapses. Slope +/- is set.		
	Level 2	1 time only measurement when the trigger level is exceeded.		
	External	Starts when a falling signal in the logic level of the external trigger terminal is detected.		
	Time	Sets start time and trigger repeat interval.		
Delay time		After the start key is pressed, the time until the start of the measurement or trigger detection is set.		
Γ	Time setting	1 sec intervals within the range of 0 to 10 sec		
Bac	k erase function	Measurement is temporarily suspended by pressing the pause key and the previous 5 seconds of data is eliminated from the calculation.		
Storage		The sound level or calculation results are recorded in the manual or auto-store mode. Data is recorded either in the internal memory or CF card. Internal memory has 1 block and it is possible to select either manual storage or auto-storage 1, 2.		

Manual store		al store	Manual recording of measurement results per address together with the measurement start time
Record data count		cord data count	
		Internal memory	Maximum 1 000 sets
		CF card*	Maximum 1 000 sets per store name, maximum 100 store names can be stored
Auto store		store	Continuous recording of measurement results at the set time interval (It is possible to append 4 types of marker data in order to be able to identify events that occur while recording) Pause does not function during auto-storage
	Au	to 1	
		Measurement tim	Maximum time: 1 000 hours (when using the CF card, refer to the following if using internal memory)
		Sound level mete mode	Continuous recording in the CF card every 100 ms of <i>L_p</i> , <i>L_{et}</i> , <i>L_{max}</i> and <i>L_{min}</i> as 1 set It is not possible to record sub-channel measurement results.
		Sampling cycl	e 100 ms (<i>L_p</i> , <i>L</i> _{eq} , <i>L</i> _{max} , <i>L</i> _{min}) only
		when using internal memor	Maximum time: 3 hours y
		Analyzer mode	Continuous recording in CF card instantaneous sound pressure level $(L_{\mathcal{P}})$ in each band level and all-pass values
		Main channel	All-pass values and band level values
		Sub-channel	All-pass values only
		Sampling cycl	e 1 ms to 1 sec, Leq,1s
		when using internal memor	Maximum 10 000 sets (1 sec or, for Leq,1s, 2.7 hours)
	Au	to 2	
		Sound level mete mode	Continuous recording in CF card of main channel and sub-channel all-pass values and measurement start time for each measurement time
		Analyzer mode	Continuous recording in CF card of main channel band levels and all-pass values and sub-channel all-pass values and measurement start time for each measurement time
		Record data coun	
Da	ta r	ecall	Stored data access and time/level display (selected frequency band 1 only)
		ry store of settings	
ivic	,	ry store or setting	Start-up is possible under file setting conditions stored in the CF card in advance.
Inp	out/o	output	
	AC	output	Selection and output of all-pass signals of either the main channel or sub-channel
		Output voltage	1 V (effective value) at range full scale
		Output resistance	600 Ω
		Load resistance	10 kΩ or more
	DC	output	Selection and output of all-pass signals of either the main channel or sub-channel
		Output voltage	3.0 V, 25 mV/dB at range full scale
		Output resistance	50 Ω
		Load resistance	10 kΩ or more
	Co	mparator output	Open collector output. Determination is also possible at the band level. The terminal is also used for the external trigger.
		Maximum applied volta	je 24 V
		Maximum driving currer	t 50 mA
	Ext	ternal trigger input	Falling edge is detected at 0V to 5 V logic level. The terminal is also used for the comparator.
USB		B	Besides connection to a PC as a storage device, it is also possible to use communication device class and execute control by communication commands (however, settings relating to the transfer of stored data and storage action are not possible with communication commands).
	Rei	mote control receptio	n Control of NA-28 by infrared remote control (remote control NA-27RC1, optional)
Po	wer	supply	Four IEC R14P (size"C") batteries or external power supply
Operating time (23 °C, normal operating conditions)			When following not functioning ; sub-channel, backlight, AC output, DC output, USB function, remote-control, autostore
	Manganese batteries		R14PU, 6 hours
	Alkaline batteries		LR14, 16 hours (10 hours if backlight is continuously activated)
	AC	adapter	NC-94B
	Exte	ernal power supply volta	ge 5 V to 6 V (rated voltage: 6 V)
	Consumption current		230 mA (during normal operation at rated voltage)
Am	bien	t conditions for operation	n -10 °C to +50 °C, 10 %RH to 90 %RH
		sions, weight	331 (H) × 89 (W) × 51 (D) mm, approx. 730 g (including batteries)
Supplied accessories			Memory card (256 MB) MC-25LC1 × 1, Storage case × 1, Soft case × 1, AC adapter NC-94B × 1,
			Windscreen WS-10 × 1, BNC-RCA cable CC-24 × 1, Strap × 1, IEC R14P (size"C") batteries (alkaline)×4

Options

name	model	
Building acoustic card	NX-28BA	
Waveform recording card	NX-28WR	
FFT analysis card	NX-28FT	
Remote control	NA-27RC1	
Sound calibrator	NC-74	
Memory card	256 MB, 2 GB	
Battery pack	BP-21A	
Dual output adaptor	CC-59S01	

* Use only RION supplied cards for assured operation.



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* Specifications subject to change without notice.

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